

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Hiroyuki NAGASAKA

Group Art Unit: 1752

Application No.: 10/589,962

Filed: August 18, 2006

Docket No.: 128675

For: EXPOSURE METHOD, EXPOSURE APPARATUS, EXPOSURE SYSTEM AND
DEVICE MANUFACTURING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

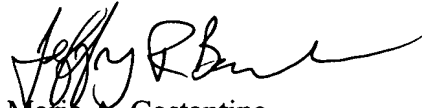
Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. Relevance of one or more non-English language reference is discussed in the present specification. See References 16 - 24, 26, 27, 41 and 42.
- ☒ 3. One or more reference cited herein was cited in the International Search Report. An English-language version of the International Search Report is attached for the Examiner's information. See References 13 - 15 and 25.
- ☒ 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- ☒ 5. An English language Abstract of one or more non-English language reference is attached hereto. See References 13 - 25, 27, 28 and 31 - 42.
- ☒ 6. An English language translation of one or more foreign reference cited herein is attached, but has not been reviewed for accuracy. See References 13 - 18, 20 -25, 27 -37, 39 and 40.

- ☒ 7. References 1 - 4 correspond to references 17 - 20, respectively.
Reference 5 corresponds to reference 24.
References 11 and 12 correspond to references 16 and 21, respectively.

Respectfully submitted,



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Date: November 30, 2006

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AUTHORIZATION**

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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 128675		APPLICATION NO. 10/589,962	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hiroyuki NAGASAKA			
				FILING DATE August 18, 2006		GROUP 1752	

U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name
	1	5,534,970	07/09/1996	NAKASHIMA ET AL.
	2	5,448,332	09/05/1995	SAKAKIBARA ET AL.
	3	4,780,617	10/25/1988	UMATATE ET AL.
	4	6,262,796 B1	07/17/2001	LOOPSTRA ET AL.
	5	5,825,043	10/20/1988	SUWA
	6	4,346,164	08/24/1982	TABARELLI ET AL.
	7	4,480,910	11/06/1984	TAKANASHI ET AL.
	8	5,610,683	03/11/1997	TAKAHASHI ET AL.
	9	5,715,039	02/03/1998	FUKUDA ET AL.
	10	2004/0165159 A1	08/26/2004	LOF ET AL.
	11	2003/0025890 A1	02/06/2003	NISHINAGA
	12	6,897,963 B1	05/24/2005	TANIGUCHI ET AL.

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Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	13	JP A 10-340846	12/22/1998	JAPAN	X	X
	14	JP A 2000-21763	01/21/2000	JAPAN	X	X
	15	JP A 2000-58436	02/25/2000	JAPAN	X	X
	16	JP A 2001-313250	11/09/2001	JAPAN	X	X
	17	JP A 06-349701	12/22/1994	JAPAN	X	X
	18	JP A 06-283403	10/07/1994	JAPAN	X	X
	19	JP A 61-044429	03/04/1986	JAPAN	X	

OTHER DOCUMENTS		
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
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Examiner:	Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.
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	20	JP A 2000-511704	09/05/2000	JAPAN	X	X	
	21	JP A 2000-164504	06/16/2000	JAPAN	X	X	
	22	JP A 06-124873	05/06/1994	JAPAN	X	X	
	23	JP A 10-303114	11/13/1998	JAPAN	X	X	
	24	JP A 10-154659	06/09/1998	JAPAN	X	X	
	25	JP A 2000-21772	01/21/2000	JAPAN	X	X	
	26	WO 2004/019128 A2	03/04/2004	WIPO			
	27	WO 09/49504	09/30/1999	WIPO	X	X	
	28	JP A 58-202448	11/25/1983	JAPAN	X	X	
	29	JP A 62-65326	03/24/1987	JAPAN		X	
	30	JP A 63-157419	06/30/1988	JAPAN		X	
	31	JP A 04-305915	10/28/1992	JAPAN	X	X	
	32	JP A 04-305917	10/28/1992	JAPAN	X	X	
	33	JP A 05-62877	03/12/1993	JAPAN	X	X	
	34	JP A 06-124873	05/06/1994	JAPAN	X	X	
	35	JP A 07-220990	08/18/1995	JAPAN	X	X	
OTHER DOCUMENTS							
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	36	JP A 08-316125	11/29/1996	JAPAN	X	X	
	37	JP A 11-176727	07/02/1999	JAPAN	X	X	
	38	JP A 59-019912	02/01/1984	JAPAN	X		
	39	DD 221 563 A1	04/24/1985	GERMANY	X	X	
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OTHER DOCUMENTS							
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